MOSFET - Power, Single **N-Channel** 40 V, 2.2 mΩ, 142 A

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFWS002N04CL Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_{.I} = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	40	V
Gate-to-Source Voltage	9		V _{GS}	±20	V
Continuous Drain		T _C = 25°C	I _D	142	Α
Current R _{θJC} (Notes 1, 2, 3, 4)	Steady	T _C = 100°C		80	
Power Dissipation	State	T _C = 25°C	P_{D}	85	W
R _{θJC} (Notes 1, 2, 3)		T _C = 100°C		27	
Continuous Drain	Steady State	T _A = 25°C	I _D	28	Α
Current R _{0JA} (Notes 1, 3, 4)		T _A = 100°C		20	
Power Dissipation		T _A = 25°C	P_{D}	3.2	W
R _{θJA} (Notes 1, 3)		T _A = 100°C		1.6	
Pulsed Drain Current	T _A = 25	°C, t _p = 10 μs	I _{DM}	706	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			Is	70.4	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 10.2 A)			E _{AS}	268	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 3)	$R_{\theta JC}$	1.8	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	46.5	

- 1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi (Ψ) is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 4. Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

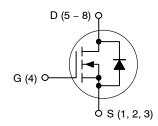


ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
40 V	2.2 mΩ @ 10 V	142 A
	3.5 mΩ @ 4.5 V	142 A

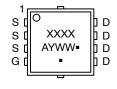
N-Channel



MARKING DIAGRAM







= Specific Device Code XXXX Α = Assembly Location

= Year WW = Work Week = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS						•	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			10	μΑ
		$V_{GS} = 0 V$, $V_{DS} = 40 V$	T _J = 125°C			250	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{G}$	_S = 20 V			100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 90 μΑ	1.2		2.0	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _[_O = 50 A		1.8	2.2	mΩ
		V _{GS} = 4.5 V, I	_D = 50 A		2.8	3.5	
Forward Transconductance	9 _{FS}	V _{DS} = 15 V, I _E	₎ = 50 A			135	S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}				2940		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = V _{DS} = 25	1.0 MHz, 5 V		1260		
Reverse Transfer Capacitance	C _{rss}	105 =			47		1
Threshold Gate Charge	Q _{G(TH)}				5.3		nC
Gate-to-Source Charge	Q_{GS}	V _{GS} = 10 V, V _{DS} = 20 V, I _D = 50 A			9.6		
Gate-to-Drain Charge	Q_{GD}				7.4		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 2	20 V, I _D = 50 A		49		nC
SWITCHING CHARACTERISTICS (No	te 6)	-					
Turn-On Delay Time	t _{d(on)}				14		ns
Rise Time	t _r	V _{GS} = 10 V, V _D	s = 32 V,		77		1
Turn-Off Delay Time	t _{d(off)}	I _D = 50	Ă		70		1
Fall Time	t _f				22		1
DRAIN-SOURCE DIODE CHARACTER	RISTICS						
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 V,$ $I_{S} = 50 A$	T _J = 25°C		0.84	1.2	V
			T _J = 125°C		0.72		1
Reverse Recovery Time	t _{RR}				54		ns
Charge Time	t _a	$V_{GS} = 0 \text{ V, } dl_S/dt = 100 \text{ A/}\mu\text{s,}$ $l_S = 50 \text{ A}$			24		
Discharge Time	t _b				30		1
Reverse Recovery Charge	Q _{RR}				43		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.

6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

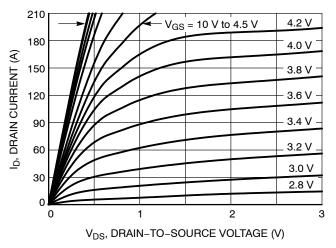


Figure 1. On-Region Characteristics

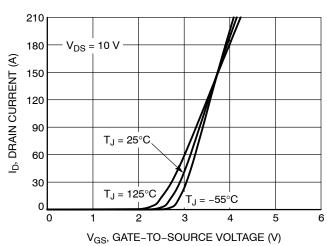


Figure 2. Transfer Characteristics

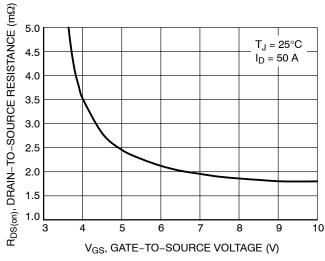


Figure 3. On-Resistance vs. Gate-to-Source Voltage

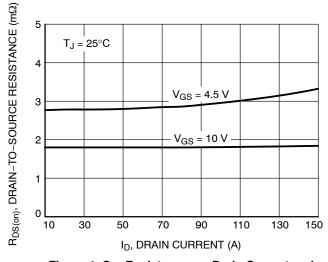


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

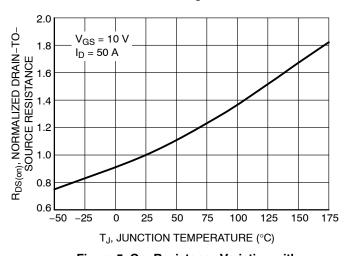


Figure 5. On–Resistance Variation with Temperature

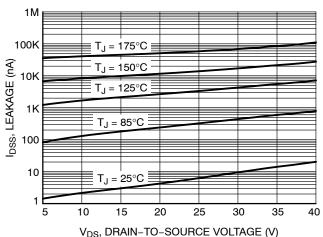


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

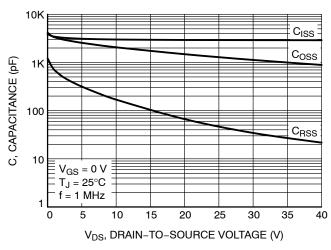


Figure 7. Capacitance Variation

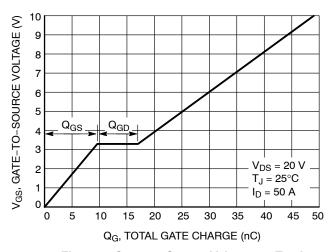


Figure 8. Gate-to-Source Voltage vs. Total Charge

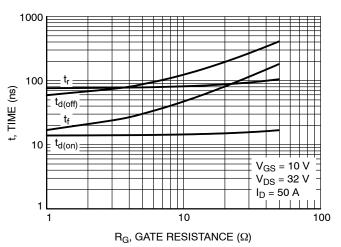


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

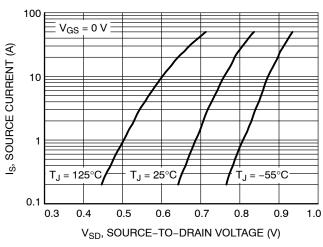


Figure 10. Diode Forward Voltage vs. Current

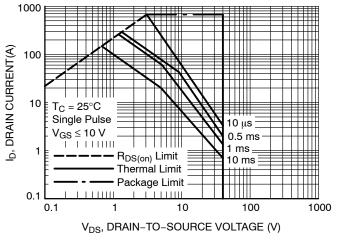


Figure 11. Maximum Rated Forward Biased Safe Operating Area

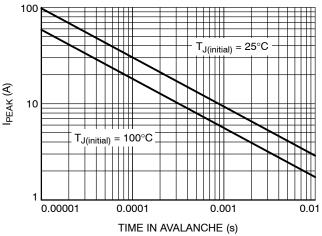


Figure 12. I_{PEAK} vs. Time in Avalanche

TYPICAL CHARACTERISTICS

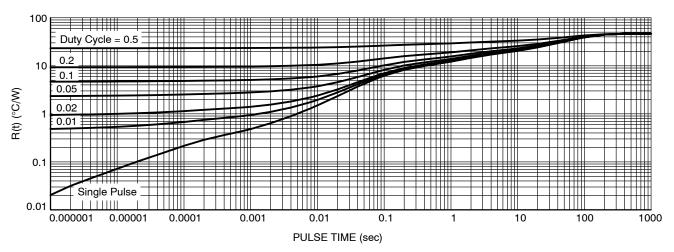


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVTFS002N04CLTAG	02NL	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFWS002N04CLTAG	02LW	WDFN8 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

WDFN8 3.3x3.3, 0.65P CASE 511DY **ISSUE A**

DATE 21 AUG 2018

MILLIMETERS

0.75

0.20

3.30

3.13

2.20

3.30

3.00

1.60

0.25

0.65 BSC

0.43

0.35

0.75

0.52

0.15

1.50

NOM MAX

0.80

0.05

0.43

0.25

3.40

3.30

2 40

3.40

3.15

1.80

0.40

0.55

0.45

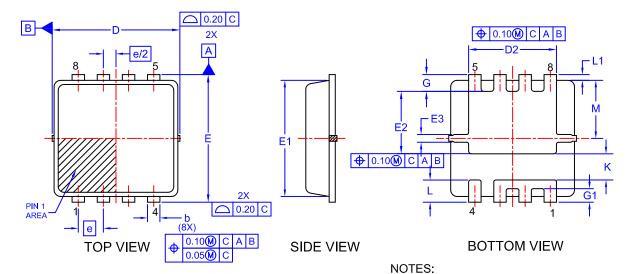
0.95

0.65

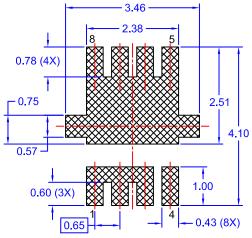
0.30

1.60

12



Θ 0.10 C ○ 0.10 C С **SEATING PLANE END VIEW**



RECOMMENDED LAND PATTERN

GENERIC MARKING DIAGRAM*

1. CONTROLLING DIMENSION: MILLIMETERS

PROTRUSIONS NOR GATE BURRS.

2. DIMENSIONS D1 & E1 DO NOT INCLUDE MOLD FLASH

DIM

Α

A1

b

D

D1

D2

Е

E1

E2

E3

е

G

G1

Κ

L

L1

М

θ

MIN

0.70

0.00

0.23

0.15

3.20

2.95

1.98

3.20

2.80

1.40

0.15

0.30

0.25

0.55

0.35

0.06

1.35

0



XXXX = Specific Device Code = Assembly Location

= Year Code WW = Work Week Code

*This information is generic. Please refer to
device data sheet for actual part marking.
Pb–Free indicator, "G" or microdot " ■",
may or may not be present. Some products
may not follow the Generic Marking.
,

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may or may not be present. Some products
may not follow the Generic Marking.

DOCUMENT NUMBER:	98AON90827G	Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	WDFN8 3.3x3.3, 0.65P		PAGE 1 OF 1	

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